

**Search Notes**

Application/Control No.

10/591,161

Examiner

VanThu Nguyen

Applicant(s)/Patent under  
Reexamination

OTSUKA ET AL.

Art Unit

2824

**SEARCHED**

Class	Subclass	Date	Examiner
365	185.33 189.01 x 189.07 230.03	3/16/2008	VTN
711	103 x	3/16/2008	VTN
711	170 x	3/16/2008	VTN

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST search, including inventors and interference searches (see print out history)	3/16/2008	VTN